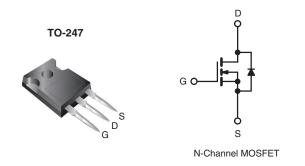


Vishay Siliconix

COMPLIANT

Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	450			
$R_{DS(on)}(\Omega)$	V _{GS} = 10 V	0.63		
Q _g (Max.) (nC)	80			
Q _{gs} (nC)	12			
Q _{gd} (nC)	41			
Configuration	Single			



FEATURES

- · Dynamic dV/dt Rating
- · Repetitive Avalanche Rated
- Isolated Central Mounting Hole
- Fast Switching
- · Ease of Paralleling
- · Simple Drive Requirements
- · Lead (Pb)-free

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-247 package is preferred for commercial-industrial applications where higher power levels preclude the use of TO-220 devices. The TO-247 is similar but superior to the earlier TO-218 package because its isolated mounting hole. It also provides greater creepage distances between pins to meet the requirements of most safety specifications.

ORDERING INFORMATION	
Package	TO-247
Lead (Pb)-free	IRFP344PbF
Lead (FD)-liee	SiHFP344-E3

ABSOLUTE MAXIMUM RATINGS T	_C = 25 °C, u	nless otherw	ise noted			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	450	V	
Gate-Source Voltage			V_{GS}	± 20	7 Y	
Continuous Drain Current	V _{GS} at 10 V	T _C = 25 °C T _C = 100 °C		9.5		
	V _{GS} at 10 V	T _C = 100 °C	I _D	6.0	A	
Pulsed Drain Current ^a			I _{DM}	38		
Linear Derating Factor				1.2	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	410	mJ	
Repetitive Avalanche Current ^a			I _{AR}	9.5	Α	
Repetitive Avalanche Energy ^a			E _{AR}	15	mJ	
Maximum Power Dissipation	ower Dissipation T _C = 25 °C			150	W	
Peak Diode Recovery dV/dt ^c			dV/dt	3.5	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for 10 s		-	300 ^d		
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
				1.1	N · m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. $V_{DD}=50$ V, starting $T_J=25$ °C, L=8.1 mH, $R_G=25$ Ω , $I_{AS}=9.5$ A (see fig. 12). c. $I_{SD}\leq 9.5$ A, $dI/dt\leq 90$ A/µs, $V_{DD}\leq V_{DS}$, $T_J\leq 150$ °C.
- d. 1.6 mm from case.

IRFP344, SiHFP344

Vishay Siliconix



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	40		
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.24	-	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.83		

PARAMETER	SYMBOL	TEST	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0$	450	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference t	to 25 °C, I _D = 1 mA	-	0.59	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V$	_{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	V _G	_S = ± 20 V	-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}		V _{DS} = 450 V, V _{GS} = 0 V V _{DS} = 360 V, V _{GS} = 0 V, T _J = 125 °C		-	25 250	μΑ
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 5.7 A ^b	_	-	0.63	Ω
Forward Transconductance	9 _{fs}	$V_{DS} = 50 \text{ V}, I_D = 5.7 \text{ A}^b$		5.0	-	-	S
Dynamic						1	
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ f = 1.0 MHz, see fig. 5		-	1400	-	pF
Output Capacitance	C _{oss}			-	370	-	
Reverse Transfer Capacitance	C _{rss}			-	140	-	
Total Gate Charge	Qg			-	-	80	
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$I_D = 8.8 \text{ A}, V_{DS} = 360 \text{ V},$ see fig. 6 and 13 ^b	-	-	12	nC
Gate-Drain Charge	Q _{gd}	See lig. 0 and 13	-	-	41	1	
Turn-On Delay Time	t _{d(on)}			-	8.7	-	
Rise Time	t _r	V _{DD} = 23	V _{DD} = 225 V, I _D = 8.8 A,		28	-	ns
Turn-Off Delay Time	t _{d(off)}	$R_{G} = 9.1 \Omega, R_{D} = 25 \Omega, \text{ see fig. } 10^{b}$		-	58	-	
Fall Time	t _f			-	27	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	5.0	-	الم
Internal Source Inductance	L _S			-	13	-	- nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	9.5	A
Pulsed Diode Forward Current ^a	I _{SM}			-	-	38	^
Body Diode Voltage	V_{SD}	$T_J = 25 ^{\circ}C, I_S = 9.5 A, V_{GS} = 0 V^b$		-	-	2.0	V
Body Diode Reverse Recovery Time	t _{rr}	- T _J = 25 °C, I _F = 8.8 A, dI/dt = 100 A/μs ^b		-	490	740	ns
Body Diode Reverse Recovery Charge	Q_{rr}				3.2	4.8	μC
Forward Turn-On Time	t _{on}	Intrinsic turn	-on time is negligible (turn	on is dor	ninated b	y L _S and	L _D)

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 µs; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

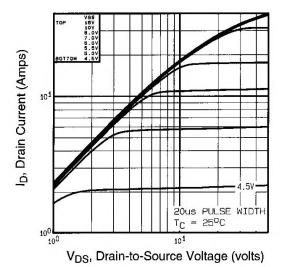


Fig. 1 - Typical Output Characteristics, $T_C = 25$ °C

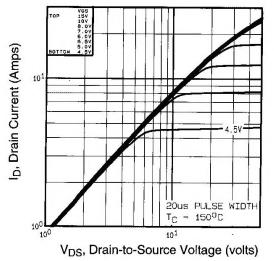


Fig. 2 - Typical Output Characteristics, $T_C = 150$ °C

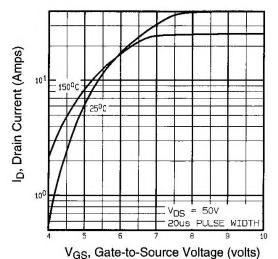


Fig. 3 - Typical Transfer Characteristics

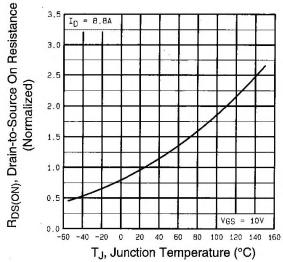


Fig. 4 - Normalized On-Resistance vs. Temperature

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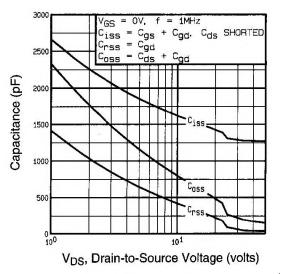


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

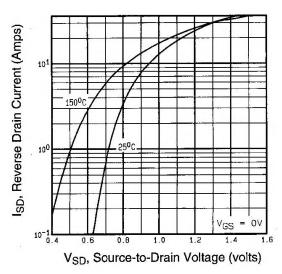


Fig. 7 - Typical Source-Drain Diode Forward Voltage

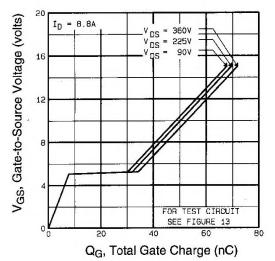


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

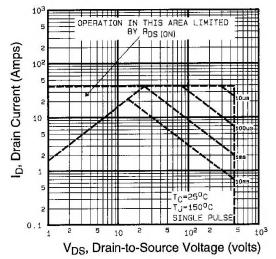


Fig. 8 - Maximum Safe Operating Area





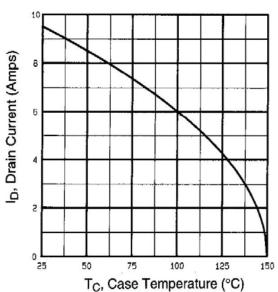


Fig. 9 - Maximum Drain Current vs. Case Temperature

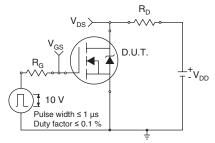


Fig. 10a - Switching Time Test Circuit

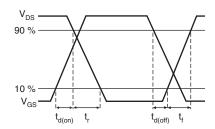


Fig. 10b - Switching Time Waveforms

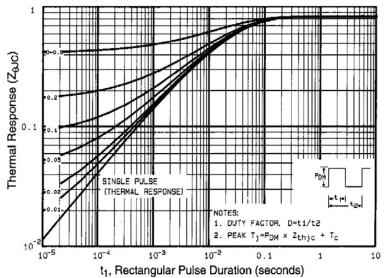


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

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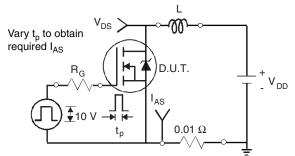


Fig. 12a - Unclamped Inductive Test Circuit

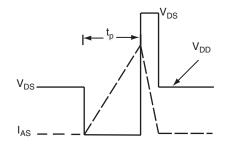


Fig. 12b - Unclamped Inductive Waveforms

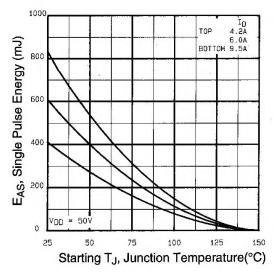


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

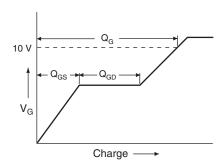


Fig. 13a - Basic Gate Charge Waveform

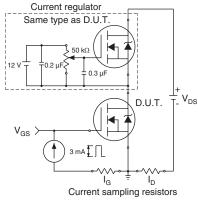
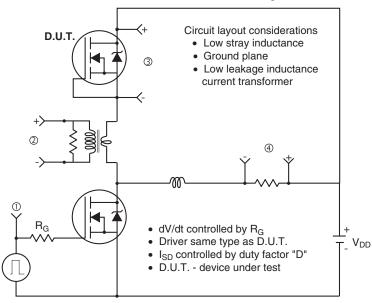
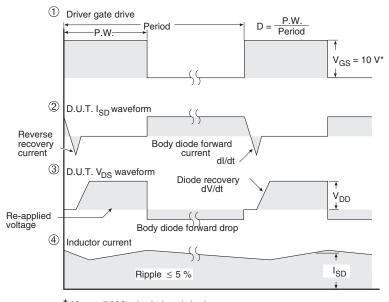


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit





* $V_{GS} = 5 V$ for logic level devices

Fig. 14 - For N-Channel

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